

#### **AUTOMOTIVE GRADE**

AUIRFN7110

# AN INFINEON TECHNOLOGIES COMPANY

#### Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified \*

### Description

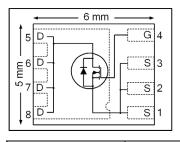
Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this product an extremely efficient and reliable device for use in Automotive and wide variety of other applications.

### **Applications**

- Injection
- DC-DC Converter
- Automotive Lighting
- E-Horn
- 48V Automotive Systems

### HEXFET® POWER MOSFET

V <sub>DSS</sub>	100V
R <sub>DS(on)</sub> typ.	11.5mΩ
max	14.5mΩ
D (Silicon Limited)	58A





G	D	S
Gate	Drain	Source

Base Part Number	Bookaga Typa	Standard	Pack	Orderable Part Number
Base Part Number	Package Type	Form	Quantity	Orderable Part Number
AUIRFN7110	PQFN 5mm x 6mm	Tape and Reel	4000	AUIRFN7110TR

### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	58	
I <sub>D</sub> @ T <sub>C(Bottom)</sub> = 100°C Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)		41	Α
I <sub>DM</sub>	Pulsed Drain Current ①	232	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ®	4.3	W
P <sub>D</sub> @T <sub>C(Bottom)</sub> = 25°C	Power Dissipation	125	٧٧
	Linear Derating Factor ®	0.029	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	133	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 13, 14, 17a, 17b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①	See Fig. 15, 14, 17a, 17b	Α
T <sub>J</sub>	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		C

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$ (Bottom)	Junction-to-Case ④		1.2	
R <sub>θJC</sub> (Top)	Junction-to-Case ④		32	°C/W
$R_{ heta JA}$	Junction-to-Ambient ©		35	
R <sub>θJA</sub> (<10s)	Junction-to-Ambient ©		22	

Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.09		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		11.5	14.5	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0	3.0	4.0	V	\\ -\\   -1004
$\Delta V_{GS(th)}$	Gate Threshold Voltage Coefficient		-8.4		mV/°C	$V_{DS} = V_{GS}$ , $I_D = 100\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 100V, V_{GS} = 0V$
				250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
$I_{GSS}$	Gate-to-Source Forward Leakage			100	nΛ	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
$R_G$	Gate Resistance		1.0		Ω	

Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Trans conductance	79			S	$V_{DS} = 50V, I_D = 35A$
$Q_g$	Total Gate Charge		49	74		I <sub>D</sub> = 35A
$Q_{gs}$	Gate-to-Source Charge		14			$V_{DS} = 50V$
$Q_gd$	Gate-to-Drain Charge		12		nC	V <sub>GS</sub> = 10V
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		37			
$t_{d(on)}$	Turn-On Delay Time		11			V <sub>DD</sub> = 50V
t <sub>r</sub>	Rise Time		23		ns	I <sub>D</sub> = 35A
$t_{d(off)}$	Turn-Off Delay Time		22			$R_G = 1.8\Omega$
t <sub>f</sub>	Fall Time		18			V <sub>GS</sub> = 10V
C <sub>iss</sub>	Input Capacitance		3050			$V_{GS} = 0V$
Coss	Output Capacitance		290		pF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		101			f = 1.0MHz

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			58		MOSFET symbol
	(Body Diode)			56	_	showing the
I <sub>SM</sub>	Pulsed Source Current			222	Α	integral reverse
	(Body Diode) ①			232		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 35A, V_{GS} = 0V$ ③
dv/dt	Peak Diode Recovery		12		V/ns	$T_J = 175$ °C, $I_S = 35A$ , $V_{DS} = 100V$
t <sub>rr</sub>	Reverse Recovery Time		27		ns	$T_J = 25$ °C, $I_F = 35A$ , $V_{DD} = 50V$
$Q_{rr}$	Reverse Recovery Charge		152		nC	di/dt = 500A/µs ③
I <sub>RRM</sub>	Reverse Recovery Current		9.8		Α	

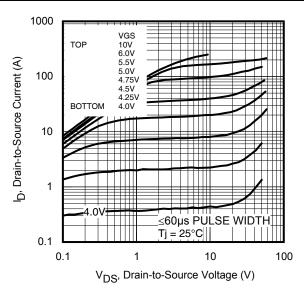


Fig. 1 Typical Output Characteristics

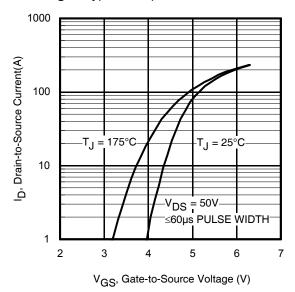


Fig. 3 Typical Transfer Characteristics

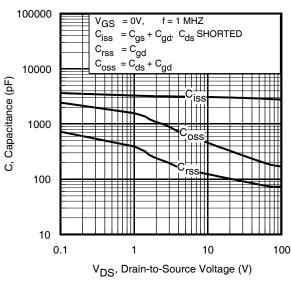


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

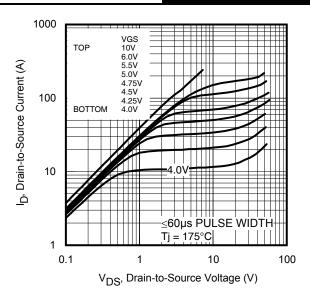


Fig. 2 Typical Output Characteristics

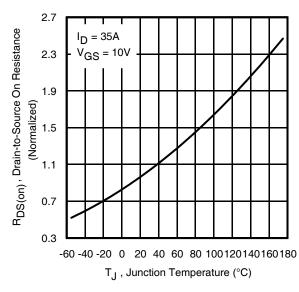


Fig. 4 Normalized On-Resistance vs. Temperature

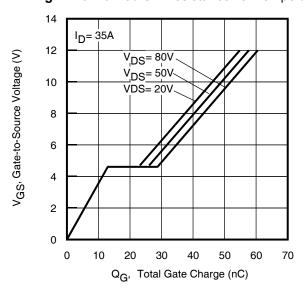


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

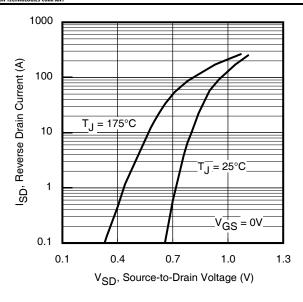


Fig. 7 Typical Source-to-Drain Diode

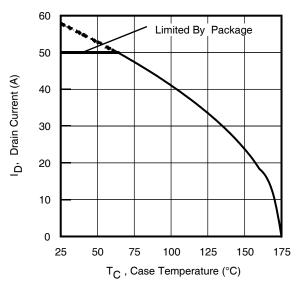


Fig 9. Maximum Drain Current vs. Case Temperature

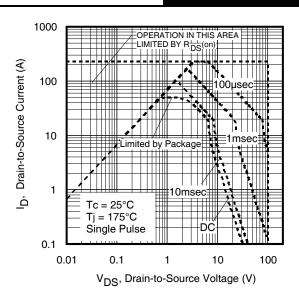


Fig 8. Maximum Safe Operating Area

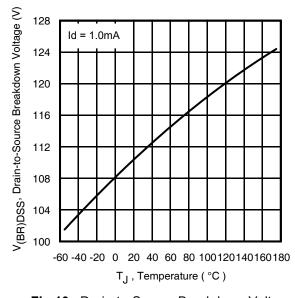


Fig 10. Drain-to-Source Breakdown Voltage

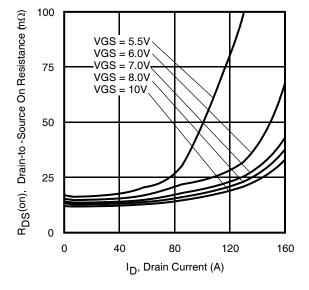


Fig 11. Typical On-Resistance vs. Drain Current

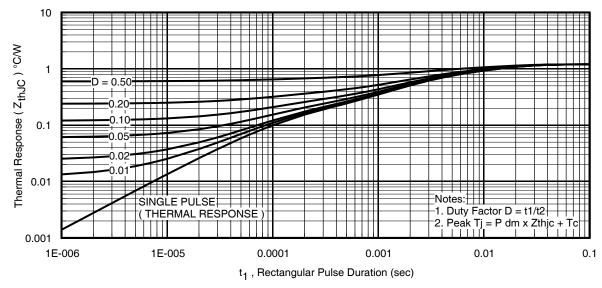


Fig 12. Maximum Effective Transient Thermal Impedance, Junction-to-Case

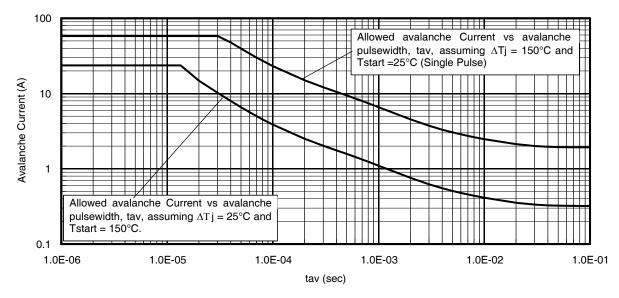


Fig 13. Typical Avalanche Current vs. Pulse Width

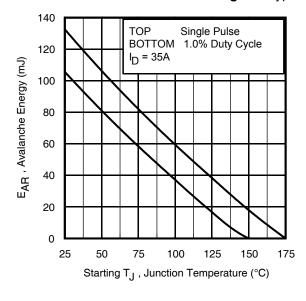


Fig 14. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 13, 14: (For further info, see AN-1005 at www.irf.com)

- 1.Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceed ed
- 3. Equation below based on circuit and waveforms shown in Figures 17a, 17b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage in crease during avalanche).
- 6. lav = Allowable avalanche current.
- $7.\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 13, 14).
- tav = Average time in avalanche.
- D = Duty cycle in avalanche = tav ·f
- ZthJC(D, tav) = Transient thermal resistance, see Figures 12)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

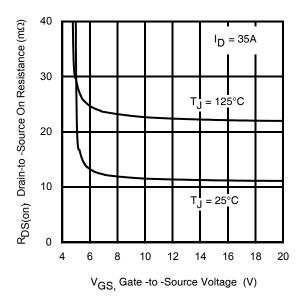


Fig 15. Typical On-Resistance vs. Gate Voltage

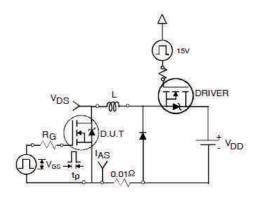


Fig 17a. Unclamped Inductive Test Circuit

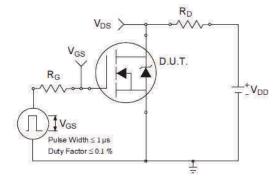


Fig 18a. Switching Time Test Circuit

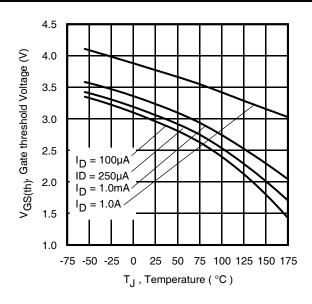


Fig 16. Threshold Voltage vs. Temperature

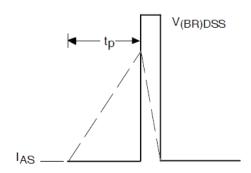


Fig 17b. Unclamped Inductive Waveforms

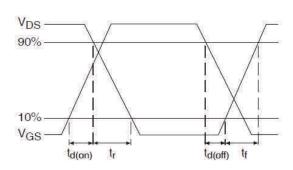


Fig 18b. Switching Time Waveforms

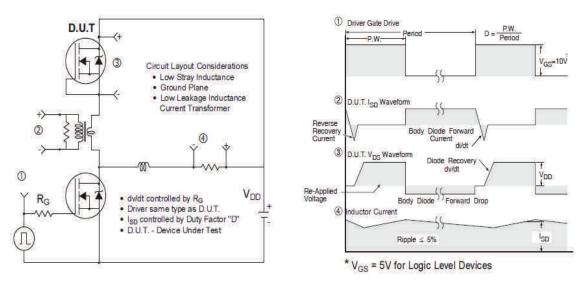


Fig 19. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

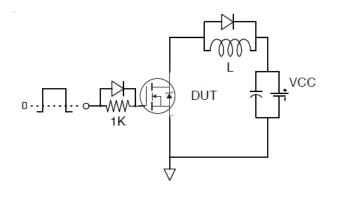


Fig 20a. Gate Charge Test Circuit

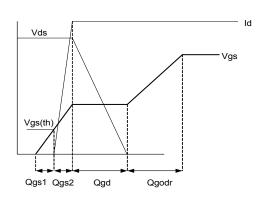
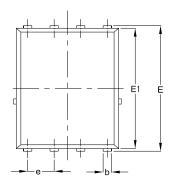
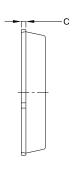


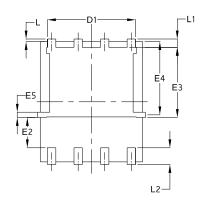
Fig 20b. Gate Charge Waveform

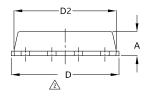


### PQFN 5x6 Outline "E" Package Details





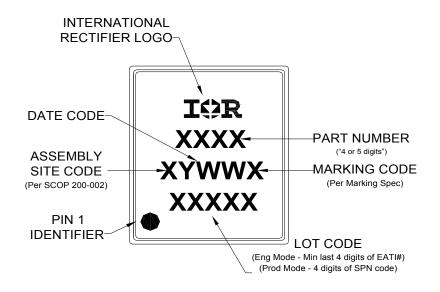




S Y	COMMON					
M B	N	1M	INCH			
0	MIN.	MAX.	MIN.	MAX.		
Α	0.90	1.17	0.0354	0.0461		
b	0.33	0.48	0.0130	0.0189		
С	0.195	0.300	0.0077	0.0118		
D	4.80	5.15	0.1890	0.2028		
D1	3.91	4.31	0.1539	0.1697		
D2	4.80	5.00	0.1890	0.1968		
Е	5.90	6.15	0.2323	0.2421		
E1	5.65	6.00	0.2224	0.2362		
E2	1.51	_	0.0594	_		
<b>E</b> 3	3.32	3.78	0.1307	0.1480		
E4	3.42	3.58	0.1346	0.1409		
<b>E</b> 5	0.18	0.32	0.0071	0.0126		
е	1.27 BSC		0.050	BSC		
L	0.05	0.25	0.0020	0.0098		
L1	0.38	0.66	0.0150	0.0260		
L2	0.51	0.86	0.0201	0.0339		
ı	0	0.18	0	0.0071		

For footprint and stencil design recommendations, please refer to application note AN-1136 at <a href="http://www.irf.com/technical-info/appnotes/an-1136.pdf">http://www.irf.com/technical-info/appnotes/an-1136.pdf</a>
For visual inspection recommendations, please refer to application note AN-1154 at <a href="http://www.irf.com/technical-info/appnotes/an-1154.pdf">http://www.irf.com/technical-info/appnotes/an-1154.pdf</a>

### **PQFN 5x6 Outline Part Marking**

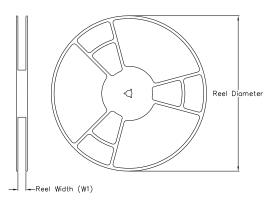


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

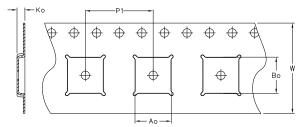


### **PQFN 5x6 Outline Tape and Reel**

## REEL DIMENSIONS

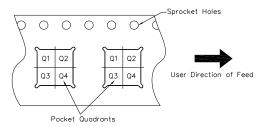


### TAPE DIMENSIONS



CODE	DESCRIPTION
Ao	Dimension design to accommodate the component width
Во	Dimension design to accommodate the component lenght
Ko	Dimension design to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

Package Type	Reel Diameter (Inch)	QTY	Reel Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Q1

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



### Qualification Information<sup>†</sup>

		Automotive (per AEC-Q101)				
Qualificati		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		PQFN 5mm x 6mm	MSL1			
	B M	Class H1C (+/- 2000V) <sup>††</sup>				
	Human Body Model	AEC-Q101-001				
ESD		Class C5 (+/- 2000V) <sup>††</sup>				
	Charged Device Model	AEC-Q101-005				
RoHS Compliant		Yes				

- † Qualification standards can be found at International Rectifier's web site: <a href="http://www.irf.com/">http://www.irf.com/</a>
- †† Highest passing voltage.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.216mH,  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 35A.
- ③ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- 4 R<sub> $\theta$ </sub> is measured at T<sub>J</sub> approximately 90°C.
- (S) When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994: <a href="http://www.irf.com/technical-info/appnotes/an-994.pdf">http://www.irf.com/technical-info/appnotes/an-994.pdf</a>



#### **IMPORTANT NOTICE**

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

IR warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with IR's standard warranty. Testing and other quality control techniques are used to the extent IR deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

IR assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using IR components. To minimize the risks with customer products and applications, customers should provide adequate design and operating safeguards.

Reproduction of IR information in IR data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alterations is an unfair and deceptive business practice. IR is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of IR products or serviced with statements different from or beyond the parameters stated by IR for that product or service voids all express and any implied warranties for the associated IR product or service and is an unfair and deceptive business practice. IR is not responsible or liable for any such statements.

IR products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of the IR product could create a situation where personal injury or death may occur. Should Buyer purchase or use IR products for any such unintended or unauthorized application, Buyer shall indemnify and hold International Rectifier and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that IR was negligent regarding the design or manufacture of the product.

Only products certified as military grade by the Defense Logistics Agency (DLA) of the US Department of Defense, are designed and manufactured to meet DLA military specifications required by certain military, aerospace or other applications. Buyers acknowledge and agree that any use of IR products not certified by DLA as military-grade, in applications requiring military grade products, is solely at the Buyer's own risk and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

IR products are neither designed nor intended for use in automotive applications or environments unless the specific IR products are designated by IR as compliant with ISO/TS 16949 requirements and bear a part number including the designation "AU". Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, IR will not be responsible for any failure to meet such requirements.

For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

#### **WORLD HEADQUARTERS:**

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105